



Interactive comment on “Artifacts from manganese reduction in rock samples prepared by focused ion beam (FIB) slicing for X-ray microspectroscopic analysis” by Dorothea S. Macholdt et al.

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See attachment

Please also note the supplement to this comment:

<https://www.geosci-instrum-method-data-syst-discuss.net/gi-2018-20/gi-2018-20-AC1-supplement.pdf>



<https://doi.org/10.5194/gi-2018-20>, 2018.

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